



Preliminary

A64S16161

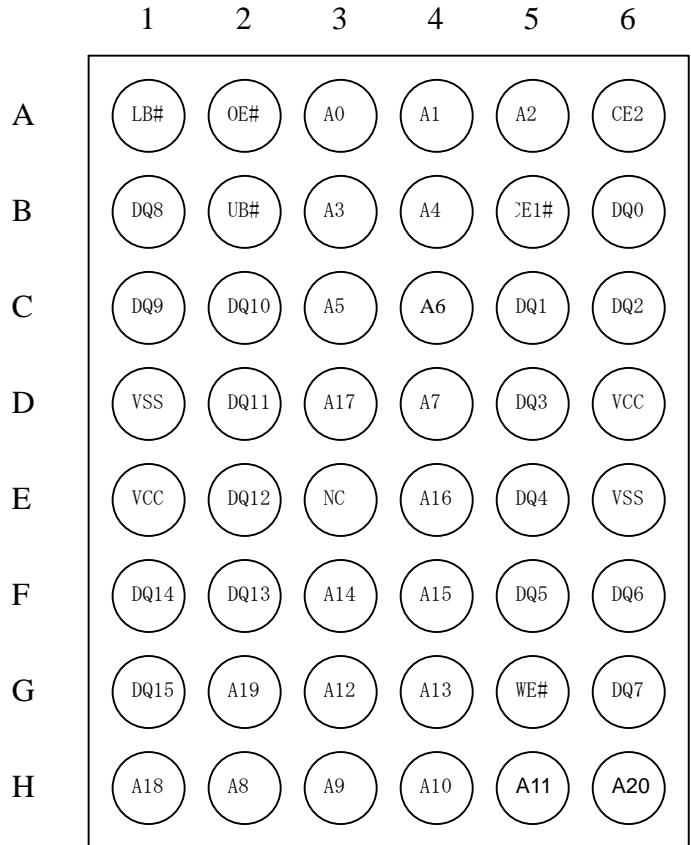
2M X 16 Bit Low Voltage Super RAM

Features

- Memory Cell : Dynamic memory(DRAM)
- Refresh: Completely free
- Power Down: Control by CS2(No Data Retention)
- Byte Control : Capable of single byte operation
- Power Consumption: 100 μ A(Standby Current)
- Operating Temperature Range: -40°C~+85°C
- Composition:2,097,152 Word X 16 Bit
- Supply Power Voltage:2.70V to 3.30V
- Access Time: 70nS
- Access Time (Page Access Read): 30nS
- I/O Terminal :Input / Output Common 3-state output

Pin Description

Pin Name	Description
CS1#	Chip select 1 (Low Active)
CS2	Chip select 2 (High Active)
WE#	Write enable (Low Active)
OE#	Output enable (Low Active)
A0 to A20	Address Input (A0 to A2 : Page Address)
IO0-7	Lower Byte Input / Output
IO8-15	Upper Byte Input / Output
LB#	Lower Byte Control (Low Active)
UB#	Upper Byte Control (Low Active)
VCC	Power Supply
VSS	Ground (0V)

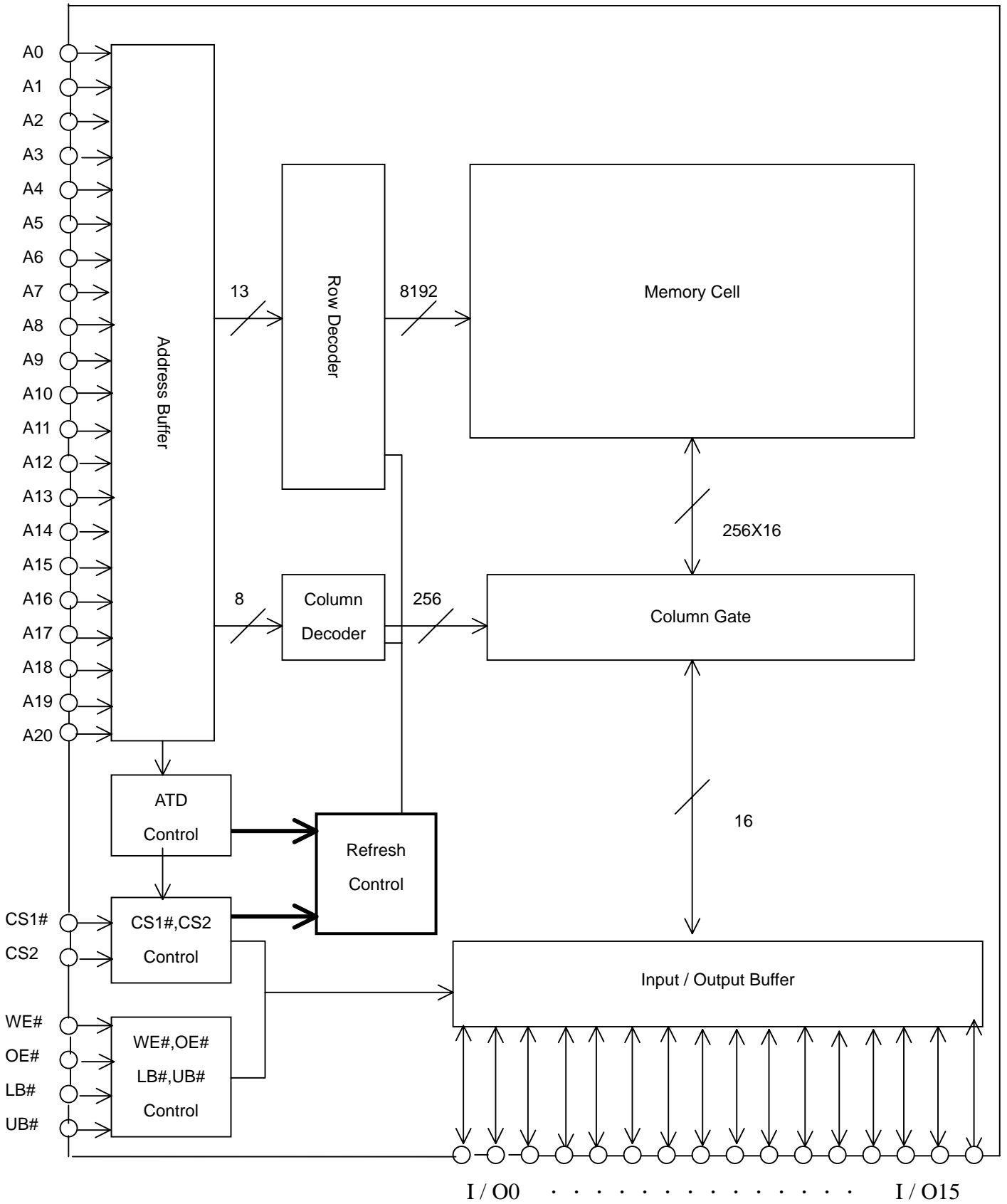


Description

A64S16161 is a virtually static RAM, which uses DRAM type memory cells, but it has refresh transparency, so that you need not to imply refresh operation. Furthermore the interface is completely compatible to a low power Asynchronous type SRAM, you can operate as same as the Asynchronous SRAM.

A64S16161 is a 2,097,152 Words X 16 bit asynchronous random access memory on a monolithic CMOS chip with marvelous low power consumption technology. Its low power and also low noise makes it ideal for mobile applications.

Block Diagram



Functions

Truth Table

A0-20	CS1#	CS2	WE#	OE#	LB#	UB#	I/O0~7	I/O8~15	Mode
V	L	H	H	L	L	L	Data-Out	Data-Out	Read
V	L	H	H	L	L	H	Data-Out	High-Z	Read
V	L	H	H	L	H	L	High-Z	Data-Out	Read
V	L	H	H	X	H	H	High-Z	High-Z	Output Disable
V	L	H	H	H	X	X	High-Z	High-Z	Output Disable
V	L	H	L	H	L	L	Data-In	Data-In	Write
V	L	H	L	H	L	H	Data-In	High-Z	Write
V	L	H	L	H	H	L	High-Z	Data-In	Write
X	H	H	X	X	X	X	High-Z	High-Z	Standby
X	X	L	X	X	X	X	High-Z	High-Z	Power Down*1

V : Valid Address. X : High or Low . *1 No Data Retention

Read Operation

It is possible to control data width by LB# and UB# pins.

(1) Reading data from lower byte

Date can be read when the address is set while holding CS1#=L, CS2=H, OE # =L , WE # = H and LB # =L.

(2) Reading data from upper byte

Date can be read when the address is set while holding CS1#=L, CS2=H, OE # =L , WE # = H and UB # =L.

(3) Reading date from both bytes

Date can be read when the address is set while holding CS1#=L, CS2=H, OE # =L , WE # = H , LB # =L and UB # =L.

(4) Page access read

Date can be read by changing A0-A2 when A3-A20 is set while holding CS1#=L, CS2=H, WE # =H, OE # =L, LB # =L and UB # =L.

Writing Operation

(1) Writing data into lower byte (WE # control)

Data can be written by adding L pulse into WE # when the address is set while holding CS1#=L, CS2=H, OE # =H, LB # =L and UB # =H.

The data on lower byte are latched up into the memory cell during WE # =L and LB # =L.

(2) Writing data into lower byte (LB # control)

Data can be written by adding L pulse into LB # when the address is set while holding CS1#=L, CS2 =H, OE#=H, UB# =H and WE#=L.

The data on lower byte are latched up into the memory cell during WE# =L and LB# = L.

(3) Writing data into upper byte (WE # control)

Data can be written by adding L pulse into WE # when the address is set while holding CS1 # =L, CS2 =H, OE # =H, LB # =H and UB # =L.

The data on upper byte are latched up into the memory cell during WE # =L and UB # = L.

(4) Writing data into upper byte (UB # control)

Data can be written by adding L pulse into UB # when the address is set while holding CS1 #=L, CS2 =H, OE #=H, LB # =H and WE #=L.

The data on upper byte are latched up into the memory cell during WE #=L and UB #=L.

(5) Writing data into both byte (WE # control)

Data can be written by adding L pulse into WE # when the address is set while holding CS1 #=L, CS2=H, OE #=H, LB #=L and UB #=L.

The data are latched up into the memory cell during WE #=L, LB #=L and UB #=L.

(6) Writing data into both byte (LB #, UB # control)

Data can be written by adding L pulse into LB# and UB# when the address is set while holding CS1#=L, CS2=H, OE #=H and WE #=L.

The data are latched up into the memory cell during WE #=L, LB #=L and UB #=L

Read or write with using both LB # and UB #, the timing edge of LB # and UB # must be same.

While I/O pins are in the output state, the data that is opposite to the output data should not be given.

Standby cycle

When CS1# is H, the device will be in the standby cycle. In this case data I/O pins are Hi-Z and all input pins are inhibited.

Power Down

When CS2 is L, the device will be in the power down. In this case, an internal refresh stops and the data might be lost.

ABSOLUTE MAXIMUM RATINGS (VSS=0V)

Parameter	Symbol	Ratings	Unit
Supply voltage	VCC	-0.5 to 3.6	V
Input voltage	VI	-0.5* to VCC+0.3	V
Input / Output voltage	V I/O	-0.5* to VCC+0.3	V
Input / Output voltage	PD	0.5	W
Operating temperature	Topr	-40 to 85	' C
Storage temperature	Tstg	-65 to 150	'C

* If pulse width is less than 5ns it is – 1.0V

ELECTRICAL CHARACTERISTICS

DC Recommended Operating Conditions (Ta=-40~85' C)

Parameter	Symbol	Min	Max	Unit
Supply voltage	VCC	2.70	3.30	V
	VSS	0	0	V
Input voltage	VIH	VCC-0.3	VCC+0.3	V
	VIL	-0.3*	0.3	V

* If pulse width is less than 5ns it is - 1.0V

DC ELECTRICAL CHARACTERISTICS

DC Characteristics (Ta=-40~85'C)

Parameter	Symbol	Condition	Min	Typ*1	Max	Unit
Input leakage current	ILI	VI=0V to VCC	-1	-	1	μA
Output leakage current	ILO	LB# and UB#=H or CS1#=H or WE#=L or OE#=H or CS2=L VI/O=0V to VCC	-1	-	1	μA
High level output voltage	VOH	IOH=-0.5mA	Vcc-0.3	-	-	V
Low level output voltage	VOL	IOL=0.5mA	-	-	0.3	V
Power Down Current	IDDPD	CS2 ≤ 0.2V	-	-	25	μA
Standby Current	IDDS	VCC-0.2V ≤ CS1#	-	60	100	μA
Operating current	IDDA1	I I/O=0mA, tcyc=70ns*2	-	25	30	mA
Operating current	IDDA2	I I/O=0mA, tcyc=1μS*2	-	3.0	3.5	mA
Operating current	IDDA3	I I/O=0mA, tcyc=70ns*3	-	20	30	mA

*1:Typical values are measured at Ta=25°C and VCC =3.0V

*2:Random access

*3:Page access read

Terminal Capacitance

(Ta=25°C f=1MHz)

Parameter	Symbol	Conditions	Min	Max	Unit
Input Capacitance	CI	VI=0V	-	8	pF
I/O Capacitance	C I/O	V I/O=0V	-	10	pF

Note : This parameter is measured by sampling , not of all products.

AC Electrical Characteristics
Read Cycle (Ta = - 30 ~ 85'C)

Parameter	Symbol	Teat Conditions	Min	Max	Unit
Read cycle time	tRC	1	70	32000	nS
Page read cycle time	tRCP	1	30	32000	nS
Address access time	tACC	1	-	70	nS
Page address access time	tACCP	1	-	30	nS
CS1 # access time	tACS	1	-	70	nS
OE # access time	tOE	1	-	35	nS
LB # , UB # access time	tAB	1	-	25	nS
CS1# high pulse width	tC1H	1	30	-	nS
Address set up to OE L #	tASO	1	-5	-	nS
CS1 # output set time	tCHZ	2	0	-	nS
CS1 # output floating time	tCLZ	2	-	15	nS
LB # , UB # output set time	tBLZ	2	0	-	nS
LB # , UB # output floating time	tBLZ	2	-	15	nS
OE # output set time	tOLZ	2	0	-	nS
OE # output floating time	tOHZ	2	-	15	nS
Output hold time	tOH	1	5	-	nS

Write Cycle (Ta= - 40~85'C)

Parameter	Symbol	Test Conditions	Min	Max	Unit
Write cycle time	tWC	1	70	32000	nS
Chip select time	tCW	1	60	-	nS
CS1# H pulse width	tC1H		30		
Address enable time	tAW	1	60	-	nS
Address set up time	tAS	1	0	-	nS
Write pulse width	tWP	1	40	-	nS
LB,UB select time	tBW	1	60	-	nS
Address hold time	tWR	1	0	-	nS
Data set up time	tDW	1	30	-	nS
Data hold time	tDH	1	0	-	nS

Power Down Cycle($T_a = -40 \sim 85^\circ \text{C}$)

Parameter	Symbol	Test Conditions	Min	Max	Unit
CS1 # H set up time for Power Down entry	tSSP	1	0	-	nS
CS1 # H hold time before Power Down exit	tSHP	1	0	-	nS
CS2 L pulse width	TC2LP	1	30	-	nS
CS1 # H hold time after Power Down exit	tHPD	1	300	-	μS

Power Up Timing Requirement($T_a = -40 \sim 85^\circ \text{C}$)

Parameter	Symbol	Test Conditions	Min	Max	Unit
CS1 # CS2 set up time after Power Up	tSHU	1	0	-	nS
Standby hold time after Power Up	tHPU	1	300	-	μS

Data Retention Timing Requirement($T_a = -40 \sim 85^\circ \text{C}$)

Parameter	Symbol	Test Conditions	Min	Max	Unit
A3 to A20 hold time during active	tBAH	1	-	32	nS
CS1# L hold time for A3 to A20 fix	tCSH	1	-	32	nS

Either tBAH or tCSH required for data retention.

Address Skew Timing Requirement($T_a = -40 \sim 85^\circ \text{C}$)

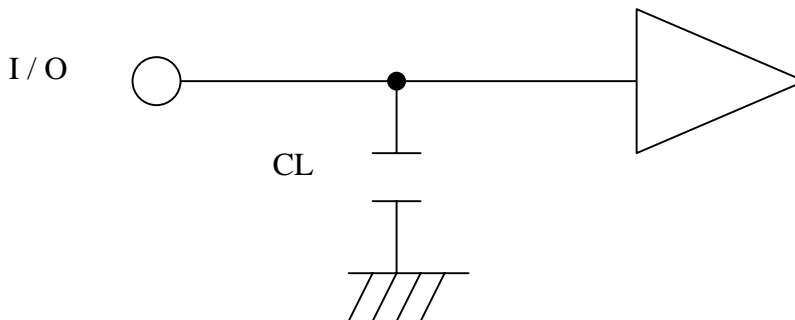
Parameter	Symbol	Test Conditions	Min	Max	Unit
Maximum address skew	tSKEW	1	-	10	nS

TEST CONDITION 1

Input pulse voltage level	$VCC - 0.3V / 0.3V$
Input ascend / descend time	$tr=tf=3nS$
Input output timing reference level	2.0V/0.8V
Output load	$CL=50pF(\text{Includes Jig capacity})+1TTL$

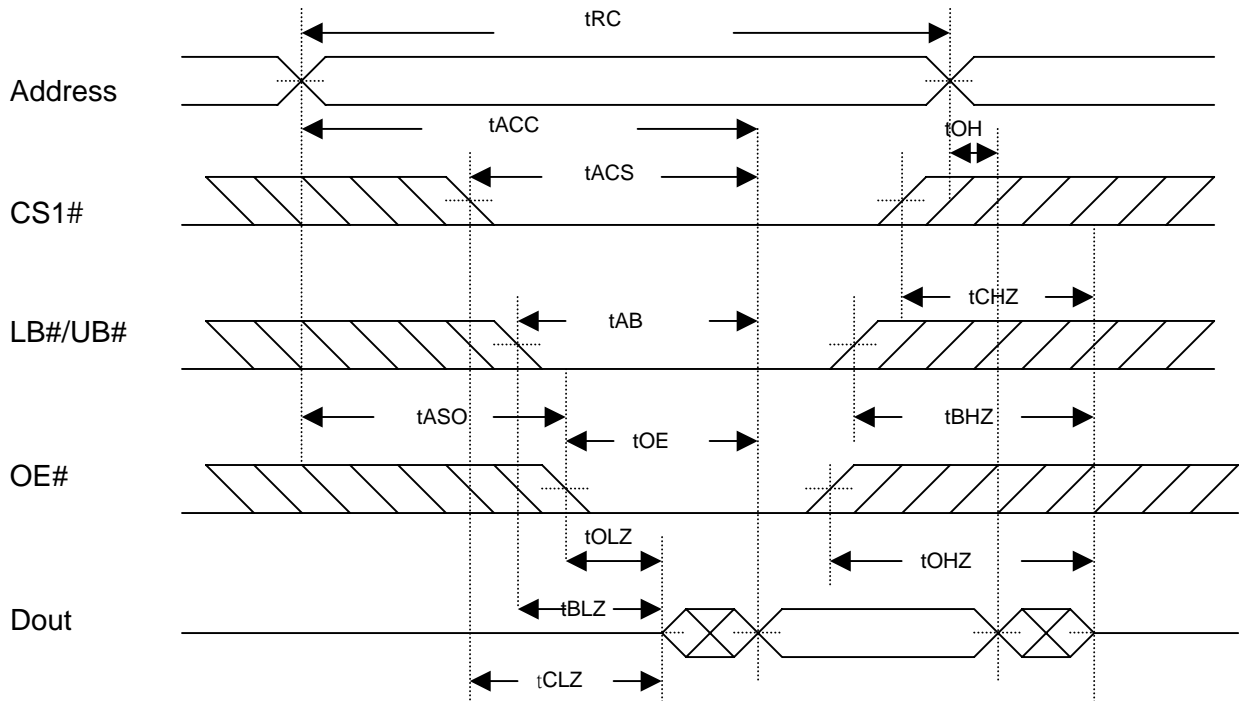
TEST CONDITION 2

Input pulse voltage level	$VCC - 0.3V / 0.3V$
Input ascend / descend time	$tr=tf=3nS$
Input output timing reference level	$\pm 100mV$ (The level change from stable voltage)
Output load	$CL=5pF(\text{Includes Jig capacity})+1TTL$



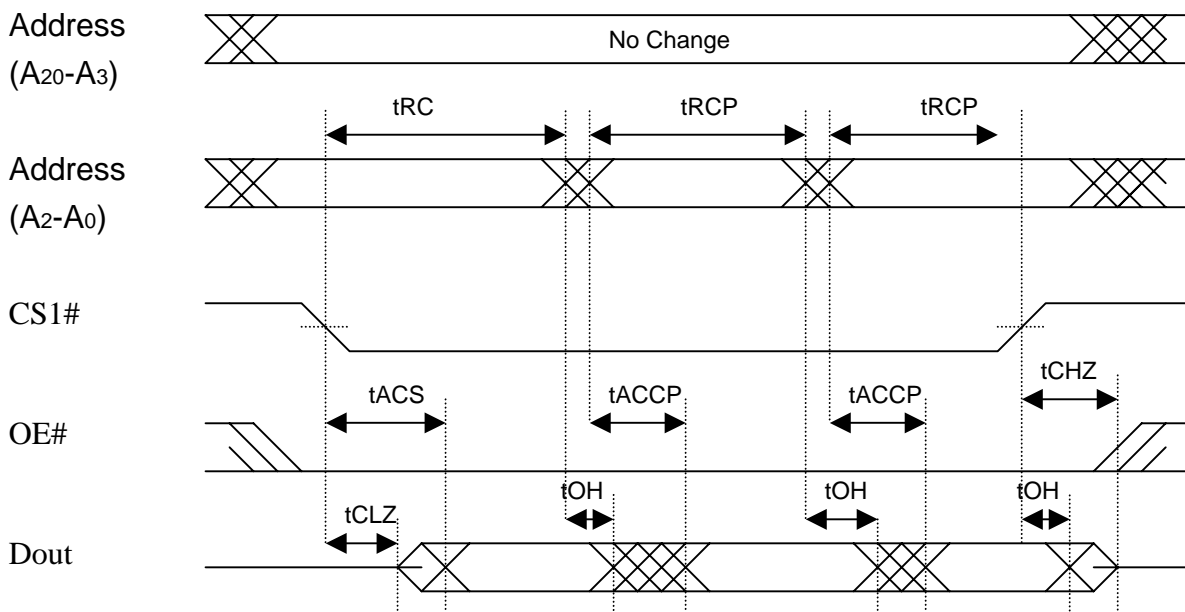
TIMING CHART

Read Cycle

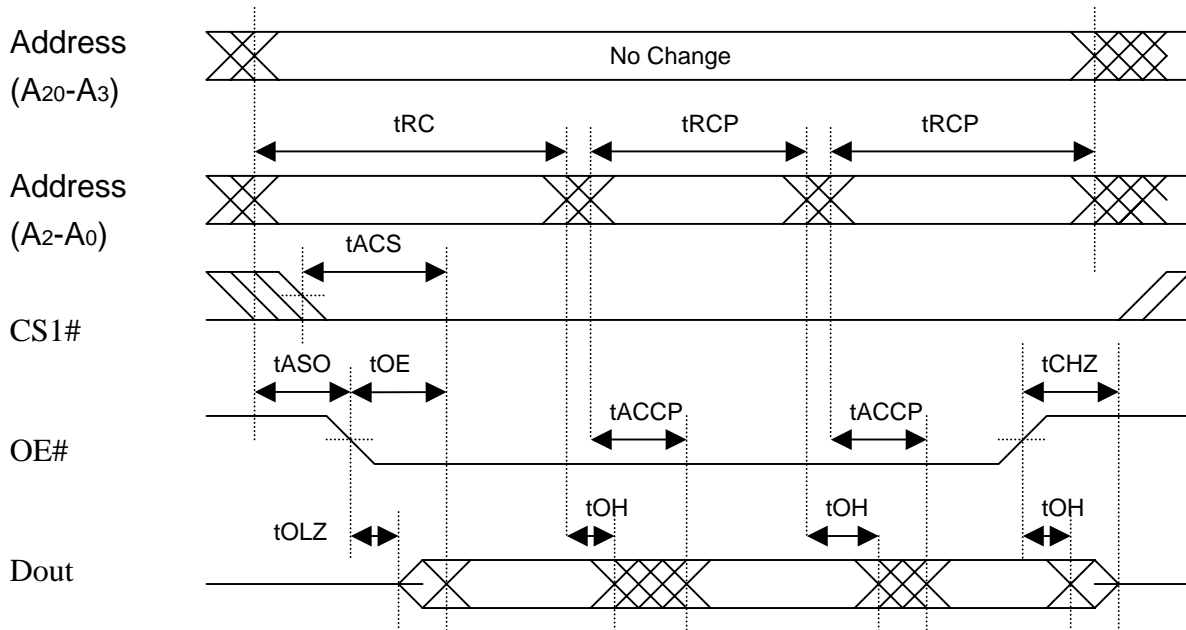


CS2 and WE # must be H level for entire read cycle.

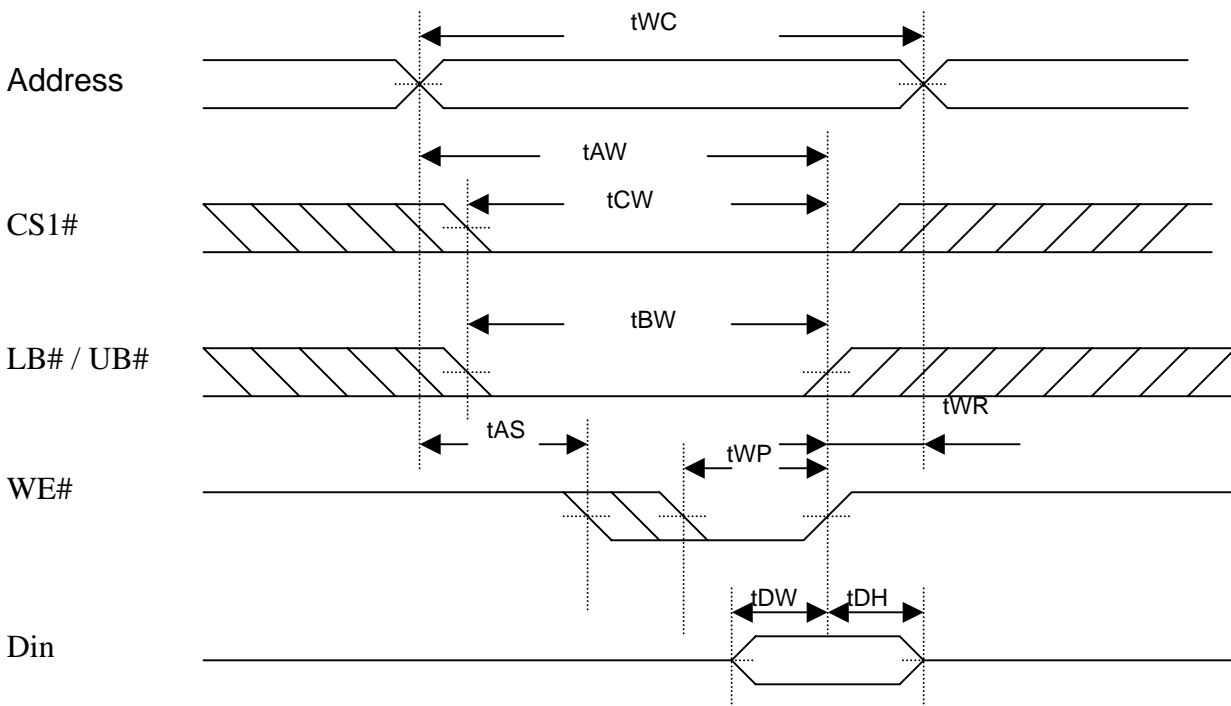
Read Cycle (Page Access [1])



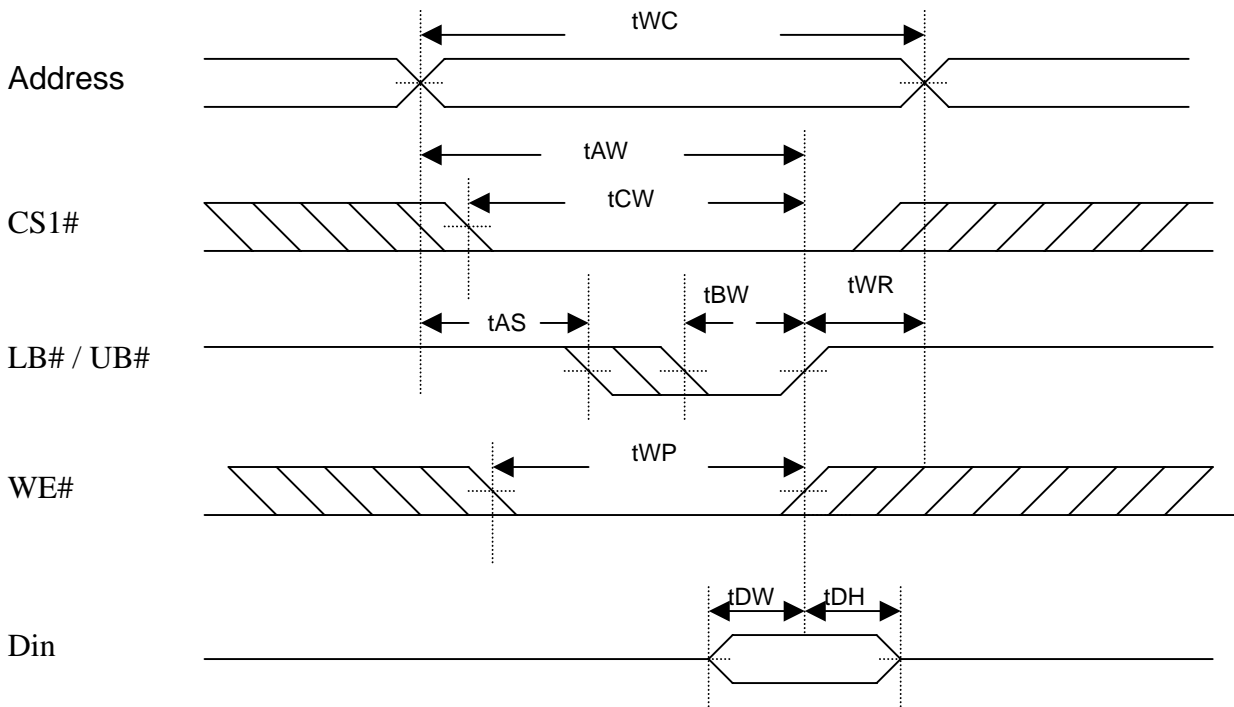
CS2 and WE # must be H level for entire read cycle.

Read Cycle (Page Access [2])


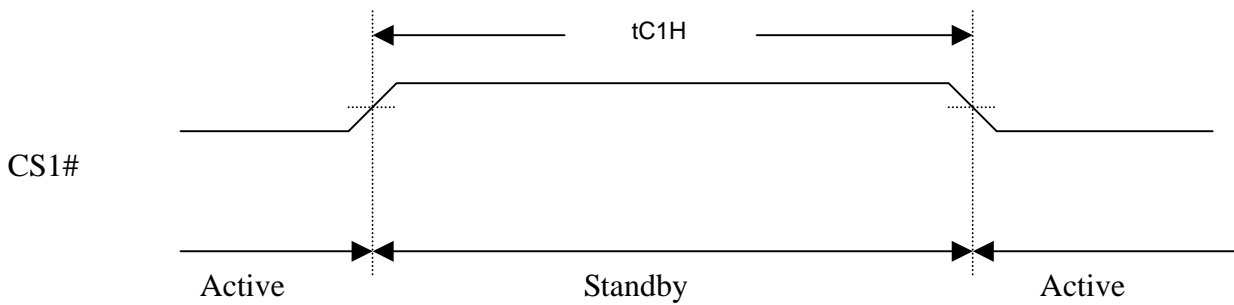
CS2 and WE # must be H level for entire read cycle.

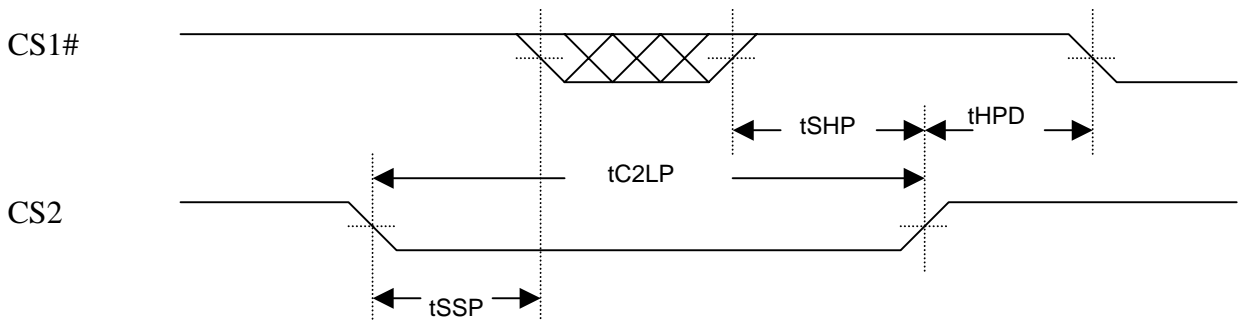
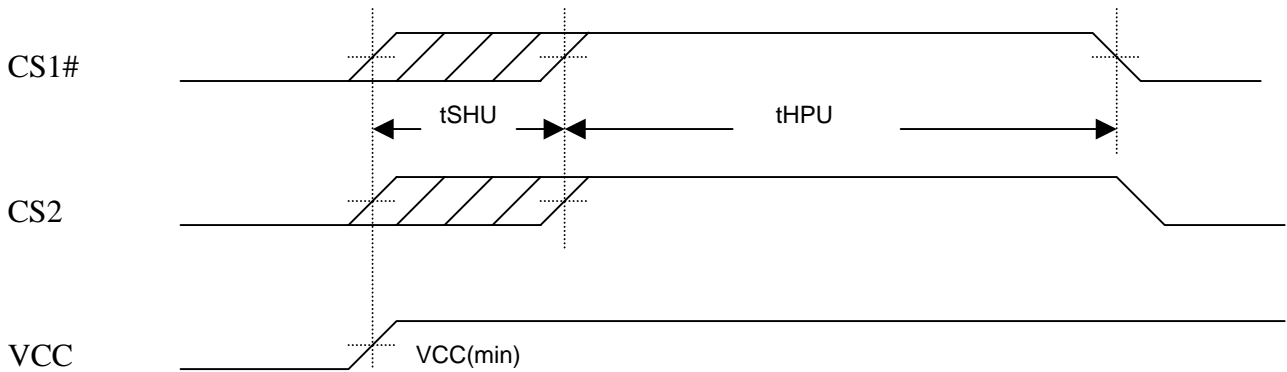
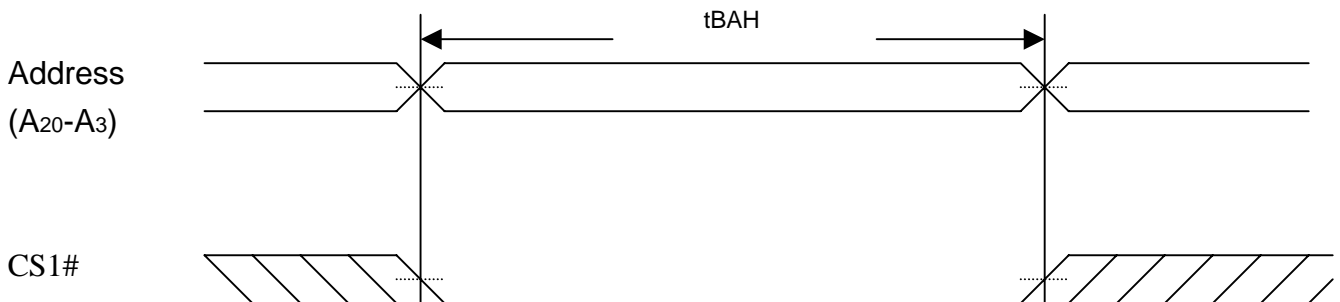
Write Cycle (WE # Control)


CS2 and OE # must be H level for entire read cycle.

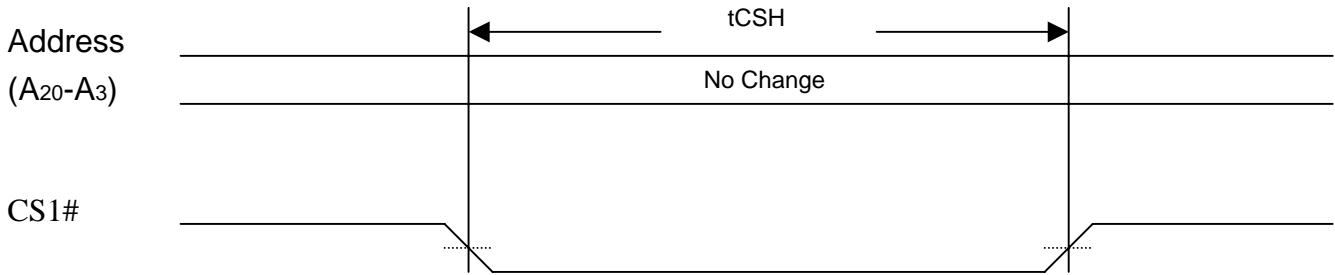
Write Cycle (LB # / UB # Control)


CS2 and OE # must be H level for entire read cycle.

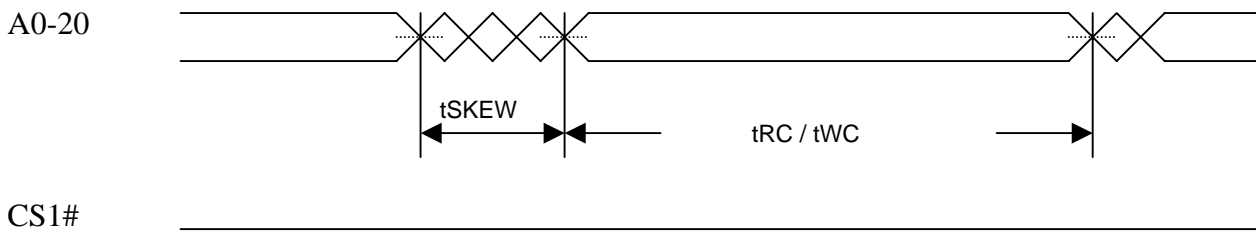
Standby


Power Down Mode Entry / Exit

Power Up

Data Retention(1)


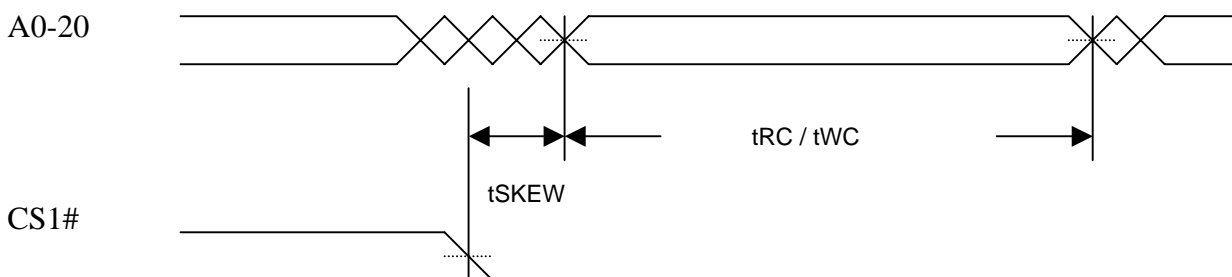
This applies for both read and write.

Data Retention (2)


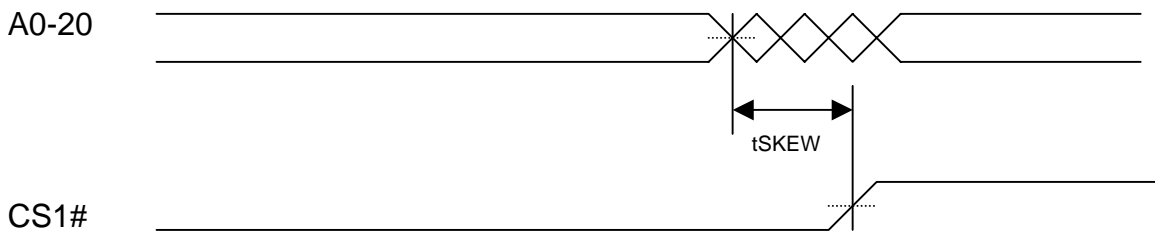
This applies for both read and write.

Address Skew(1)


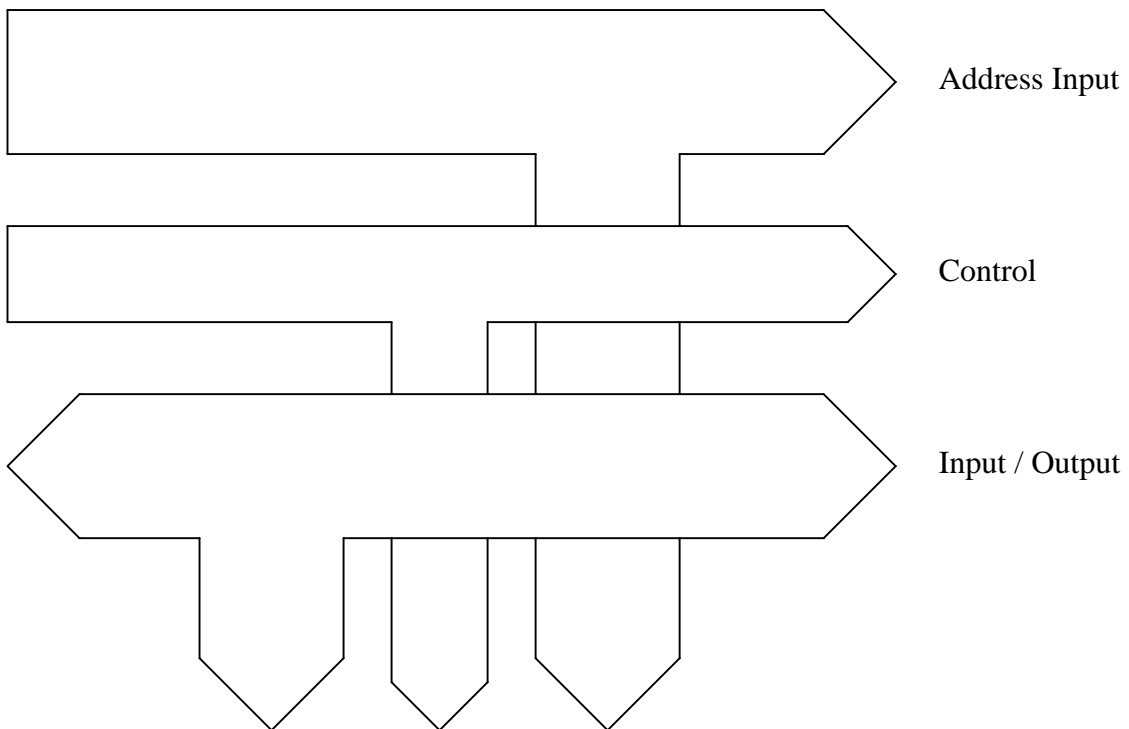
t_{SKEW} is from first address change to last address change

Address Skew(2)


t_{SKEW} is from first address change to last address change

Address Skew(3)


tSKEW is from first address change to stand-by

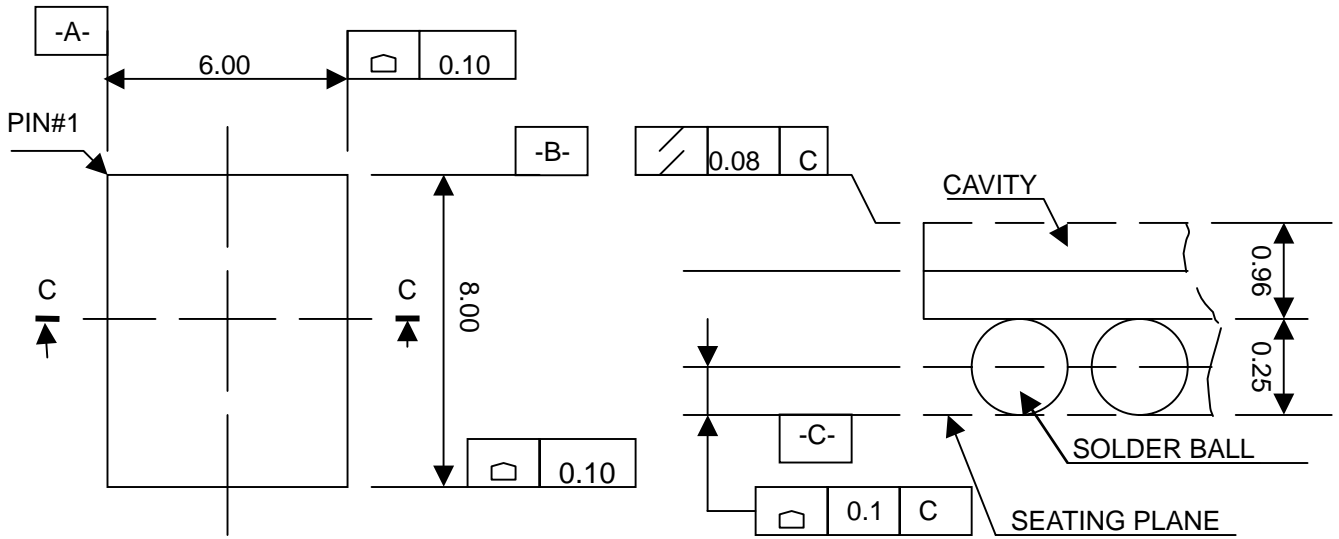
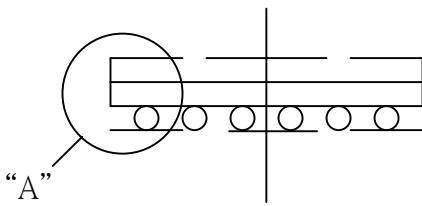
Reference External Wiring Diagram



I / O0	WE#	A0
⋮	OE#	⋮
I / O15	CS1#	A20
	CS2	
	BU#	
	LB#	
A64S16161		

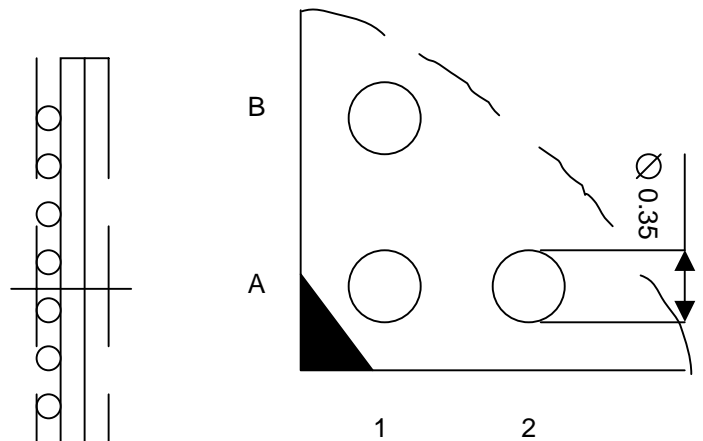
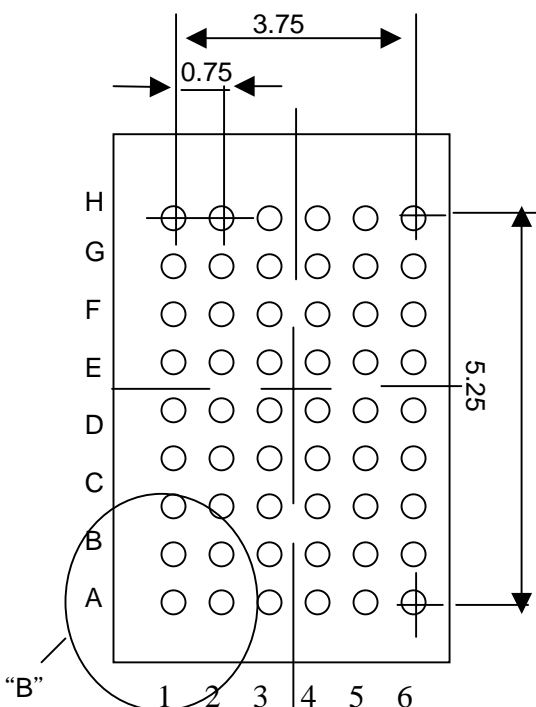
Ordering Information

Part No.	Access Time (ns)	Operating Current Max. (mA)	Power Down Mode Standby Current Max. (μA)	Package
A64S0616G-70I	70	30	25	48B Mini BGA

Note: -I is for industrial operating temperature range

48 Pins FBGA Package outline drawing

DETAIL : A

SECTION C-C

	$\varnothing 0.2$ (M)	C	A	B
	$\varnothing 0.1$ (M)	C		


DETAIL : B